


<b>Search Notes</b>  	<b>Application/Control No.</b>  10762330	<b>Applicant(s)/Patent Under Reexamination</b>  TANAKA, SATORU
	<b>Examiner</b>  BENJAMIN E LANIER	<b>Art Unit</b>  2432

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
Updated Search of 726/1-4	3/30/2010	BL

INTERFERENCE SEARCH			
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